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February 2010

FDS8958A_F085

Dual N & P-Channel PowerTrench® MOSFET

General Description

These dual N- and P-Channel enhancement mode power field effect transistors are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state ressitance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Features

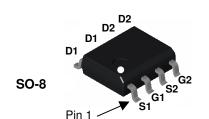
Q1: N-Channel

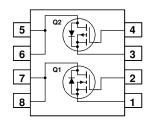
7.0A, 30V
$$R_{DS(on)} = 0.028\Omega$$
 @ $V_{GS} = 10V$ $R_{DS(on)} = 0.040\Omega$ @ $V_{GS} = 4.5V$

Q2: P-Channel

-5A, -30V
$$R_{DS(on)} = 0.052\Omega$$
 @ $V_{GS} = -10V$ $R_{DS(on)} = 0.080\Omega$ @ $V_{GS} = -4.5V$

- Fast switching speed
- High power and handling capability in a widely used surface mount package
- Qualified to AEC Q101
- RoHS Compliant





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DSS}	Drain-Source Voltage		30	30	V
V _{GSS}	Gate-Source Voltage		±20	±20	V
I _D	Drain Current - Continuous (Note 1a)		7	-5	
	- Pulsed		20	-20	Α
P _D	Power Dissipation for Dual Operation		2	2	
	Power Dissipation for Single Operation	(Note 1a)	1.6	1.6	W
		(Note 1c)	0.9	0.9	1
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	54	13	mJ
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150		°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

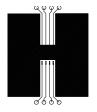
Device Marking	Device	Reel Size	Tape width	Quantity
FDS8958A	FDS8958A_F085	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Cha	racteristics						•
BV _{DSS}	Drain-Source Breakdown Voltage	$ \begin{array}{llllllllllllllllllllllllllllllllllll$	Q1 Q2	30 -30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = -250 μA, Referenced to 25°C	Q1 Q2		25 -23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V} $ $V_{DS} = -24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$	Q1 Q2			1 -1	μΑ
I_{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	All			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	All			-100	nA
On Cha	racteristics (Note 2)						
$V_{\text{GS(th)}}$		$\label{eq:VDS} \begin{split} V_{DS} &= V_{GS}, & I_D = 250 \; \mu A \\ V_{DS} &= V_{GS}, & I_D = -250 \; \mu A \end{split}$	Q1 Q2	1 -1	1.9 -1.7	3 -3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = -250 μA, Referenced to 25°C	Q1 Q2		-4.5 4.5		mV/°C
R _{DS(on)}		$\begin{array}{llllllllllllllllllllllllllllllllllll$	Q1		19 27 24	28 42 40	mΩ
		$V_{GS} = -10 \text{ V}, \qquad I_D = -5 \text{ A}$ $V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = -4.5 \text{ V}, \qquad I_D = -4 \text{ A}$	Q2		42 57 65	52 78 80	
$I_{D(on)}$		$ \begin{array}{lll} V_{GS} = -4.5 \ V, & I_D = -4 \ A \\ V_{GS} = 10 \ V, & V_{DS} = 5 \ V \\ V_{GS} = -10 \ V, & V_{DS} = -5 \ V \\ \end{array} $	Q1 Q2	20 -20			Α
g FS	Forward Transconductance	$V_{DS} = 5 V,$ $I_{D} = 7 A$ $V_{DS} = -5 V,$ $I_{D} = -5 A$	Q1 Q2		25 10		S
Dynami	c Characteristics						
C _{iss}	Input Capacitance	Q1 V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	Q1 Q2		575 528		pF
C _{oss}	Output Capacitance	Q2	Q1 Q2		145 132		pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	Q1 Q2		65 70		pF
R _G	Gate Resistance	$V_{GS} = 15 \text{ mV}, \qquad f = 1.0 \text{ MHz}$	Q1 Q2		2.1 6.0		Ω

Electri	cal Characteristics	(continued) T _A = 25 °C unless other	rwise noted		1		T
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchii	ng Characteristics (Note	2)					
$t_{\text{d(on)}} \\$	Turn-On Delay Time	Q1 $V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$	Q1 Q2		8 7	16 14	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, R_{GEN} = 6 \Omega$	Q1 Q2		5 13	10 24	ns
$t_{\text{d(off)}} \\$	Turn-Off Delay Time	Q2 $V_{DD} = -15 \text{ V}, I_D = -1 \text{ A},$	Q1 Q2		23 14	37 25	ns
t _f	Turn-Off Fall Time	V_{GS} = -10V, R_{GEN} = 6 Ω	Q1 Q2		3 9	6 17	ns
Q_g	Total Gate Charge	Q1 $V_{DS} = 15 \text{ V}, I_D = 7 \text{ A}, V_{GS} = 10 \text{ V}$	Q1 Q2		11.4 9.6	16 13	nC
Q _{gs}	Gate-Source Charge	Q2	Q1 Q2		1.7 2.2		nC
Q_{gd}	Gate-Drain Charge	$V_{DS} = -15 \text{ V}, I_{D} = -5 \text{ A}, V_{GS} = -10 \text{ V}$	Q1 Q2		2.1 1.7		nC
Drain-S	Source Diode Character	ristics and Maximum Rating	s				
Is	Maximum Continuous Drain-S	Source Diode Forward Current	Q1 Q2			1.3 -1.3	Α
I _{SM}	Maximum Plused Drain-Sour	ce Diode Forward Current (Note 2)	Q1 Q2			20 -20	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = -1.3 \text{ A}$ (Note 2)	Q1 Q2		0.75 -0.88	1.2 -1.2	V
t _{rr}	Diode Reverse Recovery Time	Q1 $I_F = 7 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$	Q1 Q2		19 19		nS
Q _{rr}	Diode Reverse Recovery Charge	Q2 $I_F = -5 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$	Q1 Q2		9 6		nC

Notes:

1. R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 78°/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125 °/W when mounted on a .02 in² pad of 2 oz copper



c) 135 °/W when mounted on a minimum pad.

- Scale 1:1 on letter size paper
- 2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%
- 3. Starting TJ = 25 °C, L = 3mH, I_{AS} = 6A, V_{DD} = 30V, V_{GS} = 10V (Q1).

Starting TJ = 25 °C, L = 3mH, I_{AS} = 3A, V_{DD} = 30V, V_{GS} = 10V (Q2).

Typical Characteristics: Q1 (N-Channel)

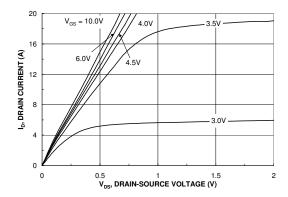


Figure 1. On-Region Characteristics.

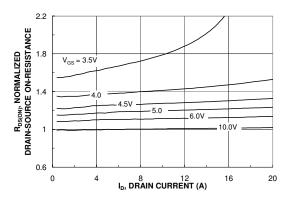


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

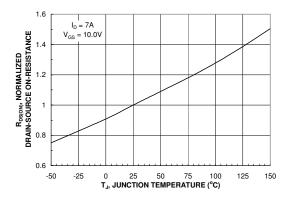


Figure 3. On-Resistance Variation with Temperature.

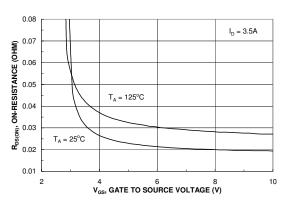


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

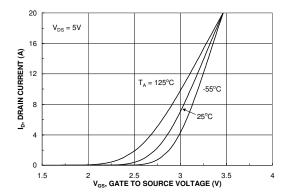


Figure 5. Transfer Characteristics.

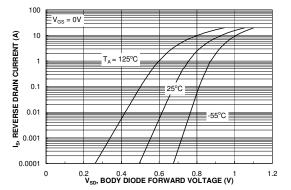


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q1 (N-Channel)

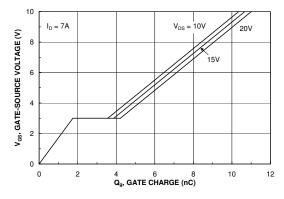
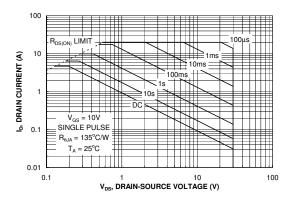


Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



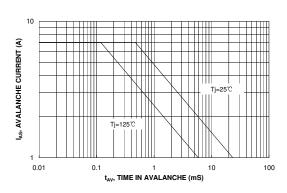


Figure 9. Maximum Safe Operating Area.

Figure 10. Unclamped Inductive Switching Capability Figure

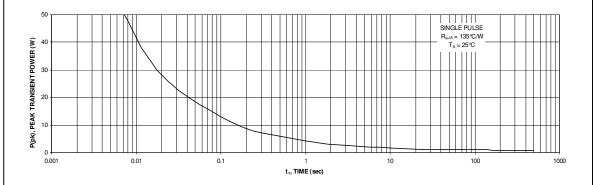


Figure 11. Single Pulse Maximum Power Dissipation.

Typical Characteristics: Q2 (P-Channel)

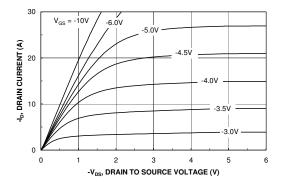


Figure 12. On-Region Characteristics.

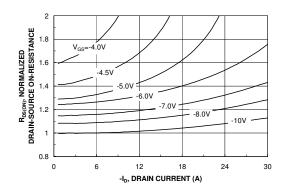


Figure 13. On-Resistance Variation with Drain Current and Gate Voltage.

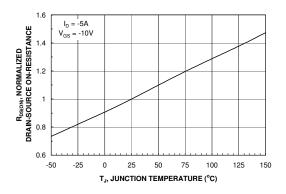


Figure 14. On-Resistance Variation with Temperature.

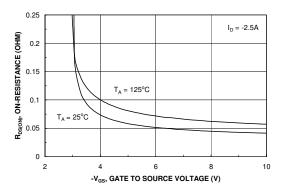


Figure 15. On-Resistance Variation with Gate-to-Source Voltage.

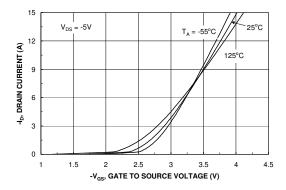


Figure 16. Transfer Characteristics.

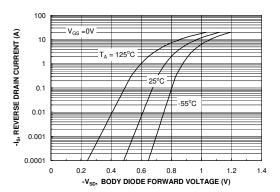


Figure 17. Body Diode Forward Voltage Variation with Source Current and Temperature.



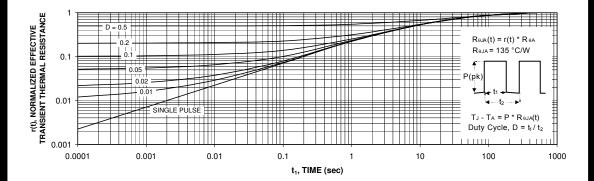


Figure 23. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.





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